

Notice of References Cited	Application/Control No. 09/776,400	Applicant(s)/Patent Under Reexamination CRAIG ET AL.	
	Examiner Gregory B Sefcheck	Art Unit 2662	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2002/0133578 A1	09-2002	Wu, C. T.	709/222
	B	US-2002/0095488 A1	07-2002	Primak, Leonard	709/223
	C	US-2002/0091855 A1	07-2002	Yemini et al.	709/238
	D	US-2002/0087726 A1	07-2002	Macpherson et al.	709/245
	E	US-6,826,690 B1	11-2004	Hind et al.	713/186
	F	US-6,614,774 B1	09-2003	Wang, Jin	370/338
	G	US-6,324,577 B1	11-2001	Hirai, Jun	709/223
	H	US-6,243,749 B1	06-2001	Sitaraman et al.	709/223
	I	US-6,009,103 A	12-1999	Woundy, Richard	370/401
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.